

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/748,642	AIKAWA ET AL.	
Examiner		Art Unit	Amy R. Cohen	
		2859	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,340,801	01-2002	Fukuda et al.	200/18
	B	US-6,828,783	12-2004	Schroter et al.	324/207.25
	C	US-6,732,438	05-2004	Enzinna, Donald John	33/1PT
	D	US-6,688,006	02-2004	Itomi, Shoji	33/1N
	E	US-6,577,984	06-2003	Clairet et al.	702/151
	F	US-6,252,223	06-2001	Kamijo, Yutaka	250/231.13
	G	US-6,170,162	01-2001	Jacobsen et al.	33/1PT
	H	US-6,112,583	09-2000	Yamamura, Kengo	73/116
	I	US-5,838,222	11-1998	Al-Rawi, Steven	338/198
	J	US-5,399,981	03-1995	Vermesse, Bernard	324/714
	K	US-5,311,666	05-1994	Jacobsen et al.	33/1PT
	L	US-5,200,747	04-1993	Betz et al.	340/870.21
	M	US-4,674,854	06-1987	Kawamura et al.	396/299

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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